

**Search Notes**

Application/Control No.

10/799,590

Examiner

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Applicant(s)/Patent under  
Reexamination

KOBAYASHI, YASUO

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	709	3/29/2006	BT
438	715	3/29/2006	BT
438	716	3/29/2006	BT
438	743	3/29/2006	BT

**INTERFERENCE SEARCHED**

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438	709	3/29/2006	BT
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438	716	3/29/2006	BT
438/743		3/29/2006	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	3/29/2006	BT